

Silicon Carbide Power MOSFET C3M<sup>™</sup> MOSFET Technology N-Channel Enhancement Mode

#### Features

- C3M<sup>™</sup> SiC MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q<sub>r</sub>)
- Halogen free, RoHS compliant

#### Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

#### Applications

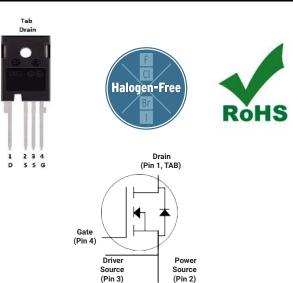
- EV chargers
- Solar inverters
- UPS
- SMPS
- DC/DC converters

#### Maximum Ratings (T<sub>c</sub>=25°C, unless otherwise specified)

Symbol	Parameter		Unit	Note
V <sub>DSmax</sub>	Drain - Source Voltage	650	V	
$V_{GSmax}$	Gate - Source voltage	-8/+19	V	Note 1
	Continuous Drain Current, $V_{GS} = 15 \text{ V}$ , $T_C = 25^{\circ}\text{C}$	120		Fig. 19
I <sub>D</sub>	Continuous Drain Current, $V_{GS} = 15 \text{ V}$ , $T_C = 100^{\circ}\text{C}$	96	А	Note 2
I <sub>D(pulse)</sub>	Pulsed Drain Current, Pulse width $t_{\scriptscriptstyle P}$ limited by $T_{\scriptscriptstyle jmax}$	418	A	
P <sub>D</sub>	Power Dissipation, $T_c=25^{\circ}C$ , $T_j=175^{\circ}C$		W	Fig. 20
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature		°C	
TL	Solder Temperature, 1.6mm (0.063") from case for 10s		°C	
M <sub>d</sub>	Mounting Torque, (M3 or 6-32 screw)	1 8.8	Nm Ibf-in	

Note (1): Recommended turn off / turn on gate voltage V\_{GS} ~ - 4V...0V / +15V Note (2): Package limited to 120 A

## Package



Part Number	Package	Marking		
C3M0015065K	TO 247-4	C3M0015065K		

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0 V, I_D = 100 \mu A$	1
M		1.8	2.3	3.6	V	$V_{DS} = V_{GS}, I_D = 15.5 \text{ mA}$	
$V_{GS(th)}$	Gate Threshold Voltage		1.9		V	$V_{DS} = V_{GS}$ , $I_D = 15.5$ mA, $T_J = 175^{\circ}C$	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		1	50	μΑ	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	
I <sub>GSS</sub>	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$	
$R_{\text{DS(on)}}$	Drain-Source On-State Resistance	10.5	15	21	mΩ	$V_{GS} = 15 \text{ V}, I_D = 55.8 \text{ A}$	Fig. 4,
DS(on)			20		11122	$V_{GS} = 15 \text{ V}, I_D = 55.8 \text{A}, T_J = 175^{\circ}\text{C}$	5,6
<b>g</b> <sub>fs</sub>	Transconductance		42		s	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 55.8 A	Fig. 7
313			40	_		$V_{DS}$ = 20 V, $I_{DS}$ = 55.8 A, $T_{J}$ = 175°C	
Ciss	Input Capacitance		5011				
C <sub>oss</sub>	Output Capacitance		289				Fig. 17, 18
C <sub>rss</sub>	Reverse Transfer Capacitance		31		рF	$V_{GS} = 0 V, V_{DS} = 400 V$	
C <sub>o(er)</sub>	Effective Output Capacitance (Energy Related)		357		1	f = 100 Khz V <sub>AC</sub> = 25 mV	Note:
C <sub>o(tr)</sub>	Effective Output Capacitance (Time Related)		516		ĺ		Note
E <sub>oss</sub>	C <sub>oss</sub> Stored Energy		29	1	μJ		Fig. 1
E <sub>ON</sub>	Turn-On Switching Energy (Body Diode)		401			$V_{DS} = 400 \text{ V}, \text{ V}_{GS} = -4 \text{ V}/15 \text{ V}, \text{ I}_{D} = 55.8 \text{ A},$	Fig. 25
E <sub>OFF</sub>	Turn Off Switching Energy (Body Diode)		254		μ	$R_{G(ext)}$ = 5 Ω, L= 57.6 μH, T <sub>J</sub> = 175 ℃ FWD = Internal Body Diode of MOSFET	
Eon	Turn-On Switching Energy (External Diode)		234			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}, I_{D} = 55.8 \text{ A},$	
EOFF	Turn Off Switching Energy (External Diode)		303		μJ	R <sub>G(ext)</sub> = 5 Ω, L= 57.6 μH, T <sub>J</sub> = 175℃ FWD = External SiC DIODE	Fig. 2
t <sub>d(on)</sub>	Turn-On Delay Time		23				
tr	Rise Time		32		ns	$\begin{split} V_{DD} &= 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V} \\ I_D &= 55.8 \text{ A}, R_{G(ext)} = 5 \Omega, L = 57.6  \mu\text{H} \\ \text{Timing relative to } V_{DS} \\ \text{Inductive load} \end{split}$	
$t_{d(off)}$	Turn-Off Delay Time		57				Fig. 2
t <sub>f</sub>	Fall Time		15				
$R_{G(int)}$	Internal Gate Resistance		1.5		Ω	$f = 1 MHz, V_{AC} = 25 mV$	
$Q_{gs}$	Gate to Source Charge		53			$V_{DS} = 400 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$	Fig. 12
$Q_{gd}$	Gate to Drain Charge		58		nC	I <sub>D</sub> = 55.8 A	
Qg	Total Gate Charge		188			Per IEC60747-8-4 pg 21	

## Electrical Characteristics ( $T_c = 25^{\circ}C$ unless otherwise specified)

Note (3): Co(er), a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 400V Co(tr), a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 400V 

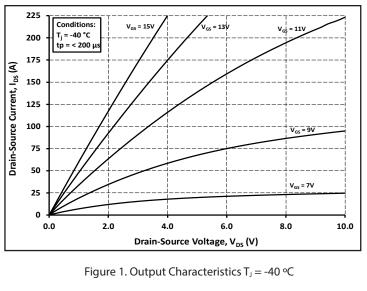
## Reverse Diode Characteristics ( $T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V <sub>SD</sub>	Diada Comunad Volta no	4.7		V	$V_{GS} = -4 \text{ V}, \text{ I}_{SD} = 27.9 \text{ A}, \text{ T}_{J} = 25 \text{ °C}$	Fig. 8,
VSD	Diode Forward Voltage	4.2		V	$V_{GS} = -4 \text{ V}, \text{ I}_{SD} = 27.9 \text{ A}, \text{ T}_{J} = 175 ^{\circ}\text{C}$	
ls	Continuous Diode Forward Current		79	А	$V_{GS} = -4 V, T_C = 25^{\circ}C$	
I <sub>S, pulse</sub>	Diode pulse Current		223	А	$V_{GS} = -4 V$ , pulse width $t_P$ limited by $T_{jmax}$	
t <sub>rr</sub>	Reverse Recover time	22		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	510		nC	$V_{GS} = -4 \text{ V}, \text{ I}_{SD} = 55.8 \text{ A}, \text{ V}_{R} = 400 \text{ V}$ dif/dt = 4000 A/µs, T <sub>j</sub> = 175 °C	
I <sub>rrm</sub>	Peak Reverse Recovery Current	39		А		
t <sub>rr</sub>	Reverse Recover time	26		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	432		nC	$V_{GS} = -4 V, I_{SD} = 55.8 A, V_{R} = 400 V$ dif/dt = 2500 A/µs, T <sub>j</sub> = 175 °C	
I <sub>rrm</sub>	Peak Reverse Recovery Current	28		А		

## Thermal Characteristics

Symbol	Parameter	Тур.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.35	°C (M)		Fig. 21
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21





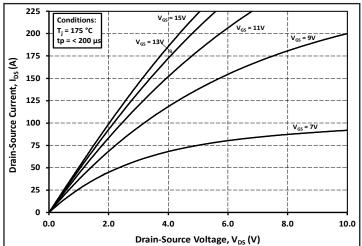


Figure 3. Output Characteristics T<sub>J</sub> = 175 °C

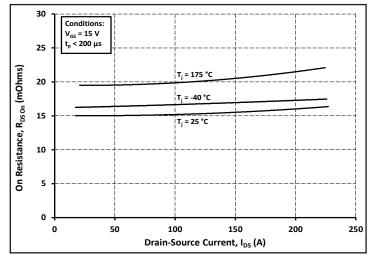


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

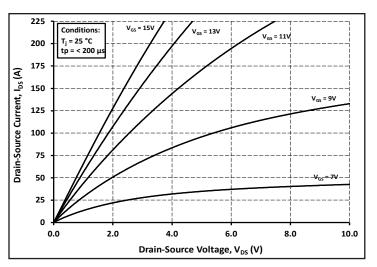
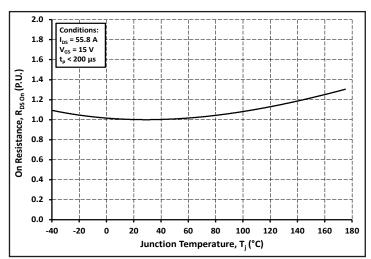


Figure 2. Output Characteristics T<sub>J</sub> = 25 °C





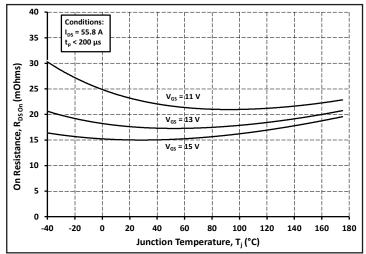
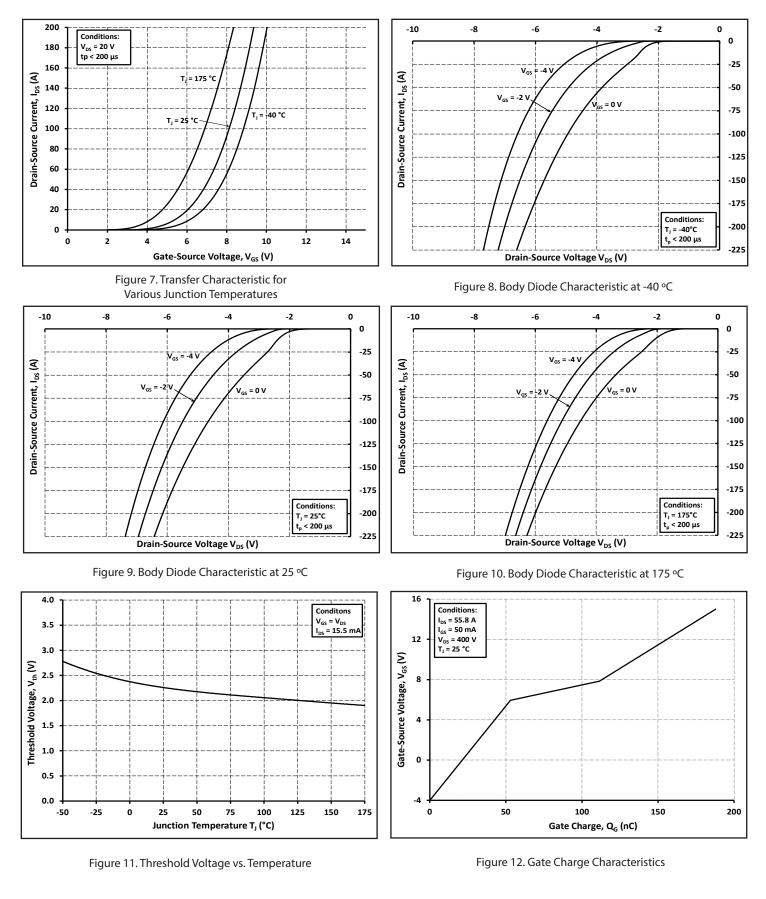


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage







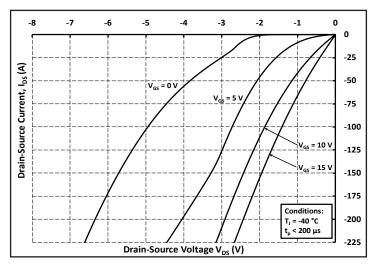


Figure 13. 3rd Quadrant Characteristic at -40 °C

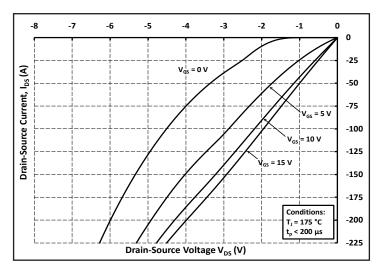
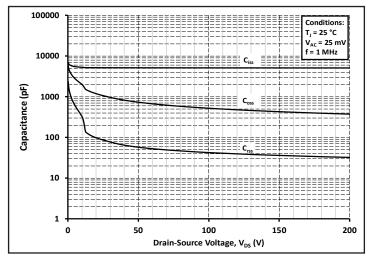
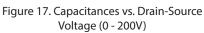


Figure 15. 3rd Quadrant Characteristic at 175 °C





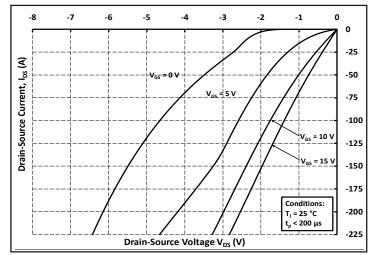
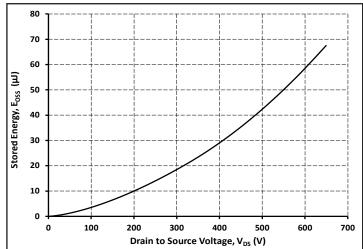


Figure 14. 3rd Quadrant Characteristic at 25 °C





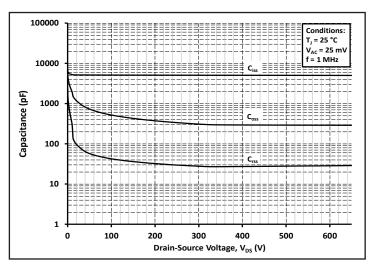
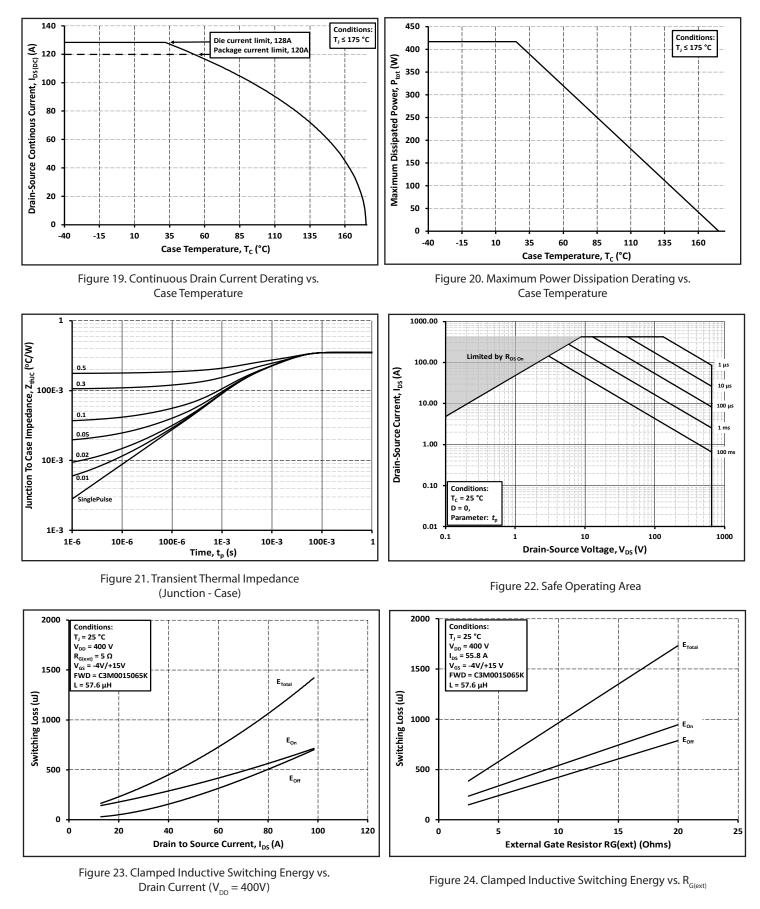


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 650V)



## Typical Performance



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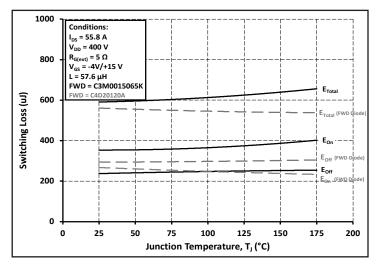


Figure 25. Clamped Inductive Switching Energy vs. Temperature

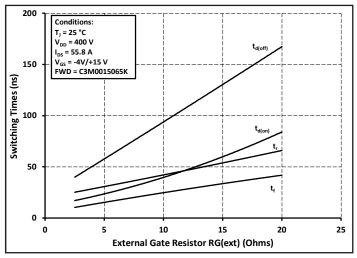


Figure 26. Switching Times vs.  $R_{G(ext)}$ 



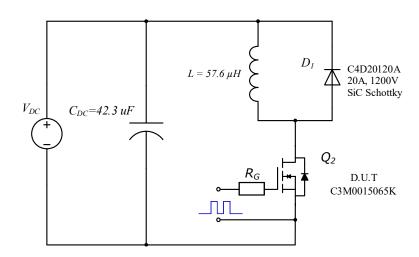


Figure 27. Clamped Inductive Switching Waveform Test Circuit

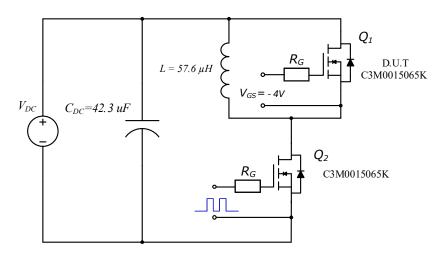
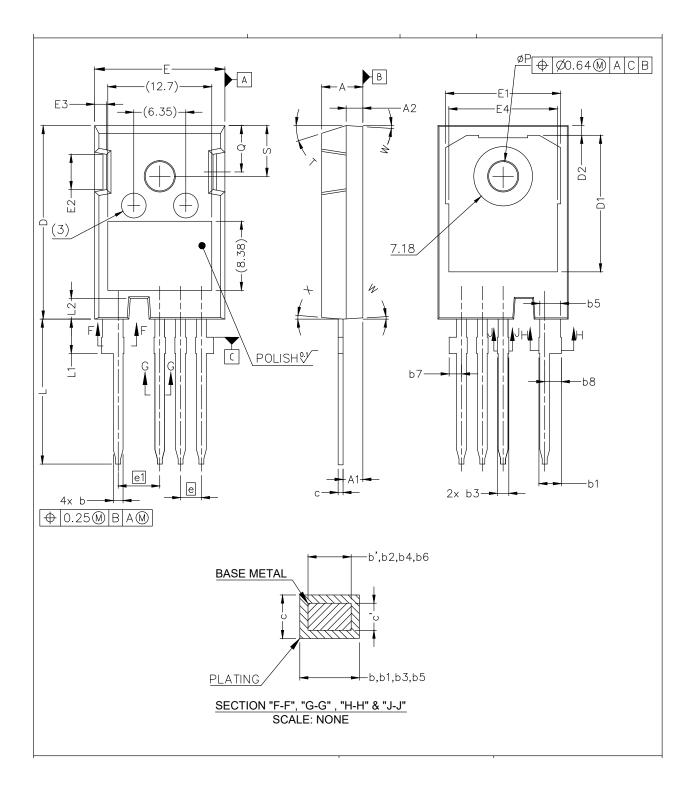


Figure 28. Body Diode Recovery Test Circuit

## Package Dimensions

TO-247-4L



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#### TO-247-4L

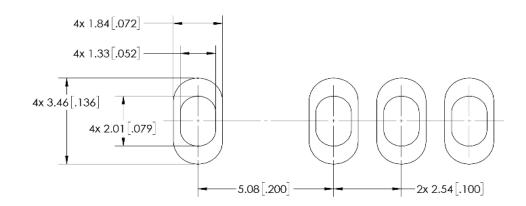
NOTE ;

- 1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT.
- 2. DIMENSIONING & TOLERANCEING CONFIRM TO
- ASME Y14.5M-1994.
- 3. ALL DIMENSIONS ARE IN MILLIMETERS.
- ANGLES ARE IN DEGREES.
- 4. 'N' IS THE NUMBER OF TERMINAL POSITIONS.
- 5. DIMENSION DO NOT INCLUDE BURR OR MOLD FLASH.

0)/14	MILLIMETERS				
SYM	MIN	MAX			
А	4.83	5.21			
A1	2.29	2.54			
A2	1.91	2.16			
b'	1.07	1.28			
b	1.07	1.33			
b1	2.39	2.94			
b2	2.39	2.84			
b3	1.07	1.60			
b4	1.07	1.50			
b5	2.39	2.69			
b6	2.39	2.64			
b7	1.30	1.70			
b8	1.80	2.20			

c'	0.55	0.65		
с	0.55	0.68		
D	23.30	23.60		
D1	16.25	17.65		
D2	0.95	1.25		
E	15.75	16.13		
E1	13.10	14.15		
E2	3.68	5.10		
E3	1.00	1.90		
E4	12.38	13.43		
е	2.54 BSC			
e1	5.08 BSC			
N*	4			
L	17.31	17.82		
L1	3.97	4.37		
L2	2.35	2.65		
øР	3.51	3.65		
Q	5.49 6.00			
S	6.04 6.30			
Т	17.5° REF.			
W	3.5 ° REF.			
X	4° REF.			

#### Recommended Solder Pad Layout







#### Notes

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